

在矽基板上研製砷化鎵太陽能電池

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摘要

和矽太陽電池相比，在單晶砷化鎵基板上成長單界面（Single-junction）砷化鎵（GaAs）太陽能電池和多界面（Multi-junction）磷化銻鎵/砷化鎵（InGaP/GaAs）太陽能電池，在AM1.5下，效率分別可達到25.7%和29.5%。磷化銻鎵/砷化鎵/鎢（InGaP/GaAs/Ge）三界面太陽能電池效率更可達到40%。雖然如此，這些太陽能電池要應用於地表上的光電系統，成本仍需降低。而製造砷化鎵太陽能電池其成本來自於單晶砷化鎵或鎢基板及需要利用磊晶技術。本論文以便宜的材料矽做為基板。為了要在矽基板上成長砷化鎵太陽能電池，故將非晶鎢薄膜沉積在矽基板表面。然後藉著熱退火製程，使非晶鎢膜再結晶（Re-crystallized）。最後，將砷化鎵太陽能電池結構成長在具有多晶鎢膜的矽基板上。

關鍵詞：砷化鎵；太陽能電池；鎢；再結晶

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